Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,536	OHASHI ET AL.	
Examiner	Art Unit	
Edward Tolan	3725	

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Class	Subclass	Date	Examiner
72	379.2	9-27-07	4
	350	1	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
72.	350	9-27-47	4	
11.	379.2	11	11	
Interference Search printout		9-27-57	9	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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